1	Revision 1
2	Solving the Iron Quantification Problem in Low kV EPMA: An essential step toward
3	improved analytical spatial resolution in electron probe microanalysis. I. Olivines
4	
5	<u>Aurélien Moy^{1,*}</u> , John Fournelle ¹ and Anette von der Handt ²
6	^{1.} Department of Geoscience, University of Wisconsin, Madison, WI 53706, USA.
7	^{2.} Department of Earth Sciences, University of Minnesota, Minneapolis, MN 55455, USA.
8	*Corresponding author. Email: amoy6@wisc.edu
9	
10	ABSTRACT
11	
12	The relatively recent entry of field emission electron microprobes into the field of
13	microanalysis provides another tool for the study of small features of interest (e.g., mineral and
14	melt inclusions, exsolution lamellae, grain boundary phases, high-pressure experimental
15	charges). However, the critical limitation for accurate quantitative analysis of these
16	submicrometer- to micrometer-sized features is the relationship between electron beam potential
17	and electron scattering within the sample. In order to achieve submicrometer analytical volumes
18	from which X-rays are generated, the beam accelerating voltage must be reduced from 15-20 kV
19	to ≤ 10 kV (often 5 to 7 kV) to reduce the electron interaction volume from ~3 μ m to ~0.5 μ m in
20	common geological materials. At these low voltages, critical Ka X-ray lines of transition
21	elements such as Fe are no longer generated, so L X-ray lines must be used. However, applying
22	the necessary matrix corrections to these L lines is complicated by bonding and chemical peak
23	shifts for soft X-ray transitions such as those producing the Fe L α X-ray line. It is therefore

24	extremely challenging to produce accurate values for Fe concentration with this approach. Two
25	solutions have been suggested, both with limitations. We introduce here a new, simple and
26	accurate solution to this problem, using the common mineral olivine as an example. We also
27	introduce, for the first time, olivine results from a new analytical device, the Extended Range
28	Soft X-ray Emission Spectrometer.
29	Keywords: EPMA, Olivine, Low kV, Iron, Microprobe, SXES, EMPA.
30	
31	INTRODUCTION
32	
33	The electron probe microanalyzer (a.k.a., electron microprobe) has been an invaluable
34	tool for Earth and planetary science since 1958, when its inventor Raimond Castaing and
35	researcher Fredriksson (1958) determined that tiny (<60 µm) spherules found in deep sea
36	sediments were in fact extra-terrestrial, by matching spherule compositions to the unique Fe:Ni
37	signature of iron meteorites. Over the intervening five decades, the electron microprobe has been
38	essential in virtually every aspect of geochemistry, mineralogy and petrology of both terrestrial
39	and extra-terrestrial materials.
40	Electron microscopes and microprobes traditionally have used bent tungsten wire
41	filaments as their beam source (and occasionally LaB ₆). Over the past decades, many scanning
42	electron microscopes (SEM) and transmission electron microscopes (TEM) have switched to
43	cold field emission (FE) gun beam sources. These FE electron sources provide brighter beams
44	(smaller diameter, higher electron flux) relative to the traditional sources (Vladár and Postek

46 resolution images. However, the long-term instability of cold-emission sources makes them

45

2009), making images from FE SEMs significantly sharper and providing higher spatial

inadequate for the demands of quantitative analysis. The advent of thermal Schottky emissiontype sources, which facilitate similarly small beam diameters but are more stable, represents a
key advance that enables not only equivalent imaging to FE SEMs but higher spatial resolution
quantitative analysis than traditional electron microprobes.

51 An example is given in Figure 1, where a secondary electron image (SEI) of an iron 52 oxide crystal in NIST glass K409 (described in Fournelle et al. 2016) was taken with a JEOL 53 JXA-8530FPlus electron microprobe. Here, the beam diameter can be determined using the 54 edge resolution technique as described by Barkshire et al. (2000): the beam diameter 55 corresponds to the distance over which some percentage change in signal intensity occurs in a 56 scan over a sharp edge between two features. For the line crossing the interface in Figure 1a, 57 the associated image intensity values are given in Figure 1b. Optimally, the adjacent dark and 58 bright areas are "flat". However, in reality there are edge effects in many instances, so an error 59 function is fit to normalize each of the darker and brighter regions. Traditionally, the image 60 resolution or "beam diameter", is defined as the distance over which there is a signal rise from 61 either 10 to 90%, 16 to 84%, or 25 to 75%. Following this convention, the beam diameter 62 could be defined correspondingly as 38, 58, or 72 nanometers. Current usage seems to prefer 63 the intermediate 16-84% rise (International Organization for Standardization, 2003).

However, even if electron images can be acquired with 10s to 100s of nanometer spatial resolution, the fact that an electron beam is generated by a field emission source does not change the fundamental physical processes by which electrons are scattered within the specimen and from which X-rays are generated. Indeed, to accurately probe small features, e.g. small inclusions, it is important to have a good estimate of the X-ray lateral resolution achievable. This 69 concept is not only governed by the beam size but also the electron ionization range, through the70 beam potential.

Typically, although not exclusively, Earth science researchers operate electron microprobes at gun voltages of 15 kV¹ for silicates, carbonates, phosphates, etc., and 20 kV for sulfides (and either voltage for metal oxides). These electron beam voltages result in electron scattering interaction volumes on the order of 2 to 3 μ m, with the primary X-rays generated within these volumes being much too large for many small features of interest.

76

77 Monte Carlo Modelling of X-ray Generation

To estimate the X-ray lateral resolution in addition to the beam diameter, the electron ionization range must be estimated. Analytical expressions aimed at calculating this electron ionization range were developed since the beginning of the electron microprobe era (Castaing 1960; Duncumb 1960; Anderson and Hasler 1966; Reed 1966) up to recently (Hovington et al. 1997; Merlet and Llovet 2012). However, Fournelle et al. (2016) showed that these models have limitations, especially for low accelerating voltages.

Another approach to estimating X-ray lateral resolution is to create a Monte Carlo simulation, wherein a large number of "random walks" of high energy electrons impinge upon and penetrate a specified material of a given geometry, and the occurring physical processes (e.g., elastic and inelastic scattering, inner shell ionization, photoelectric absorption) are included in

¹ The physical terms kV and keV are used here in the strict sense: kV refers to an electrical potential (as between the cathode and anode of the source), whereas keV refers to an energy of a "particle" such as an electron or photon.

88 the computer codes. The speed of the simulation scales with the degree of simplification and 89 approximation utilized. Three freely available programs of note are CASINO (Hovington et al. 90 1997), DTSA-II (Ritchie 2011), and PENEPMA/PENELOPE (Salvat et al. 2013). Many 91 microanalysts utilize these simulations to estimate the interaction volume for particularly small 92 sized features of interest prior to setting the appropriate beam energy for EPMA operation. 93 The Monte Carlo simulation shown in Figure 2 illustrates that the electron beam energy 94 is the primary factor in determining the size of the zone where X-rays are produced, not the 95 electron beam source whether it be tungsten, LaB₆ or field emission source. The outer contour 96 represents where the generation of Mg K α X-rays in an Fo80 olivine is only 1% of the maximum 97 produced intensity from a 15 kV source. This contour is only slightly smaller for the field 98 emission source, slightly less than 2 µm laterally, compared to approximately 2.2 µm laterally 99 for the tungsten source-the difference being approximately equal to the proportional difference 100 in beam diameters (under the general assumption that the electron beam has a Gaussian 101 distribution). It is worth noting that Figure 2 only describes the generation of the Mg K α X-rays 102 and does not take matrix absorption effects into consideration. Indeed, because of the absorption 103 of the X-rays leaving the sample, the emitted X-ray generation volume will be slightly different 104 from the generated X-ray production (or ionization range) volume.

Fournelle et al. (2016) showed that estimates of the ionization range by Monte Carlo simulation programs (in particular PENEPMA) matched those of experiments well when using a limited set of experimental data at 5 and 7 kV. This corroborates the usefulness of the Monte Carlo simulations to predict the analytical spatial resolution of EPMA measurements.

109

110 **Decreasing the Accelerating Voltage**



114 Monte Carlo simulations (Figure 3) demonstrate the critical importance of reducing the 115 accelerating voltage from 15 kV down to less than half of that. Considering again an Fo80 116 olivine, the PENEPMA Monte Carlo simulations suggest that the electron interaction volumes 117 for both tungsten and FE sources are significantly reduced. Using the 99% criterion, the tungsten 118 Mg K α lateral width drops from ~2.2 μ m to ~800 nm when going from 15 to 7 kV. The maximum 119 depth decreases from ~1.6 μ m to ~500 nm and there is a similar reduction for FE lateral width, 120 from ~1.75 μ m to ~600 nm; and depth from ~1.5 μ m to ~400 nm.

121 It is worth noting that at very low accelerating voltage or at very low overvoltage 122 (depending on the X-ray line studied) and depending on the density and composition of the 123 material analyzed, the diameter of the X-ray generation volume may approach the diameter of 124 the electron beam. In such a case, the beam diameter, and thus the electron source type, will have 125 a major influence on the size of the X-ray lateral spatial resolution.

126

These simulations show that the key factor for improved analytical spatial resolution is the accelerating voltage rather than the electron beam size. However, we would like to note several things here: (1) FE imaging in the electron probe can provide the researcher with a more critical view for "targeting" the material to be probed, illuminating inclusions too small to be analyzed, but useful to <u>avoid</u> when focusing upon the host material, such as microlites in volcanic glass (Ken Severn, pers. comm.) (2) The previous Monte Carlo simulations assume a uniform distribution of the electron beam density. It is possible that the FE source may have a denser

134 electron density in the central core compared to the traditional Gaussian-shape of the tungsten 135 and LaB₆ filaments, so that it may feasibly be possible to qualitatively image (X-ray map) at a 136 tighter spatial resolution, while not enough for full quantitation. (3) The FE high electron density 137 impacting the specimen can produce more damage than that from the tungsten filament, and in 138 many cases operators of FE instruments (especially for geological materials) end up defocusing 139 the beam—resulting in no gain in analytical spatial resolution compared with tungsten filament 140 instruments. On the other hand, the FE's beam diameter remains smaller than from the 141 comparable W source at high beam currents, and doesn't dramatically increase at low kV, giving 142 the operator a choice of smaller achievable beam diameters relative to W instruments. (4) There 143 are anecdotal accounts of FE sources lasting for 5-10 years, so that the higher cost of the tip is 144 more than offset relative to frequent replacements of tungsten tips, with long uninterrupted 145 service. Thus, pros and cons must be weighed when making a purchasing decision for a new 146 instrument.

147

148 Another factor affecting spatial resolution in EPMA is secondary fluorescence: X-rays 149 generated, not by the incident high energy electrons, but by both characteristic and continuum 150 X-rays. These secondary fluoresced X-rays can be generated from tens to hundreds of 151 micrometers away, though are primarily a problem for trace element analysis in normal 15 to 20 152 kV EPMA. But for small, micrometer and sub-micrometer features, the "other" phase is very 153 close and must be considered. Operation at low kV reduces this effect somewhat as the high-154 energy characteristic X-rays (and the high-energy bremsstrahlung photons), the major source of 155 production of secondary fluorescence X-rays, are no longer created. However, lowering the 156 accelerating voltage does not completely eliminate this effect. Monte Carlo programs such as

157 PENEPMA/PENELOPE have the ability to model the extent of secondary fluorescence and also158 provide the ability to correct for it.

159

160 **Problems of low kV EPMA**

161 It is clear that lowering the kV is important to achieve increased spatial resolution in 162 EPMA (regardless of electron source). However, there are two main issues which became 163 important when considering operating at low kV: (1) X-ray lines generated and used at higher 164 kV may no longer be available at lower kV, for example, the important element iron (the critical 165 excitation energy for Fe K α is 7.114 keV (Zschornack 2007)); and (2) because the electrons no 166 longer penetrate deeply into the material, the state of the sample surface becomes more critical: 167 the smoothness of surface polish, the surface fidelity and cleanliness, and the conductive coating 168 (of both the unknown and the standard). And because the beam no longer penetrates nor spreads 169 out radially as much, there is much more concentrated energy in a smaller region, and sample 170 damage can be magnified significantly. These issues are discussed in several recent publications, 171 e.g., Kearns et al. 2014; Saunders et al. 2014. However, we focus here upon the first issue, the 172 problem of the L lines of a critical transition metal, iron, in a common rock forming mineral, 173 olivine.

174

Olivine was studied for two reasons: one, it is a relatively simple mineral phase, consisting dominantly of iron, magnesium, silicon and oxygen but showing a wide compositional range. Second, olivine is a key constituent in the Earth's mantle and crustal rocks as well as extraterrestrial materials. EPMA analysis of small olivine grains or with complex zoning such as found in chondrules (Libourel and Portail 2018) or in diffusion and grain growth studies (Shea
et al. 2015) might necessitate working at low kV to achieve the desired spatial resolution.

- 181
- 182
- 183

184 The problem of low kV EPMA of iron-bearing materials

It has been shown that it is difficult to do accurate EPMA with the L α lines of the 185 transition metals using the traditional matrix corrections (ZAF, phi-rho-Z), e.g., Llovet et al. 186 (2012), Gopon et al. (2013), and Buse and Kearns (2018). The reasons include peak shape 187 188 changes and position shifts due to differences in bonding between the standard and the 189 unknowns, as well as problems with the accuracy of mass absorption coefficients (MACs), with 190 the L α peak lying directly across the absorption edge. There is a major increase in the MAC for 191 Fe L α by Fe from right before the edge at 710 eV (Zschornack 2007), with a value of ~2180 cm^2/g at 704 eV (Heinrich 1987) to past the edge, with a value of ~14400 cm²/g at 717 eV 192 193 (Heinrich 1987). This complex situation causes varying "self absorption" yields for different 194 MACs for the same element for different Fe-bearing compounds—which is not the case for the 195 MAC of the Fe K α X-ray line by atoms of Fe.

196 Gopon et al. (2013) found that the "non-traditional" L ℓ ("el el", L3-M1 transition) for Fe 197 could be successfully utilized for quantification as it lay far from any Fe absorption edge. The 198 use of the L ℓ line of Fe compared to the L α line works well for iron silicides but its lower relative 199 count rates in many minerals and glasses of interest to geoscientists leads to diminished statistical 190 precision. To compensate for the low X-ray intensity of the Fe L ℓ line, measurements require 191 longer counting times or the use of a monochromator crystal with a high detection efficiency. In

202 addition, the Fe L ℓ line partially interferes with the Fe Ln line and the second order of diffraction 203 of the Mg K α X-ray line. Therefore, the accuracy of quantification using the Fe L ℓ line in 204 olivines at low to moderate Fe concentrations is increasingly dependent on the magnitude of the 205 interference correction for Mg. Also, even though the Lℓ line originates from a transition 206 between "inner" electron shells, recent studies by Terauchi and Sato (2018) show that the Fe Lt 207 line peak position can shift between different iron oxides and then, potentially, between other 208 iron compounds. Thus, it would be desirable if the analytical problems of the L α line could be 209 resolved as to enable its use in low kV EPMA. Llovet et al. (2016) found that for the transition 210 metal Ni, if an empirical correction was applied to the fluorescence yield (a fundamental 211 parameter in the matrix correction) of the Ni L α X-ray line, in addition to the reevaluation of the 212 Ni La MAC by atoms of Ni, there was an improvement in the matrix-corrected results. 213 Following this methodology, Buse and Kearns (2018) recently evaluated the use of the Fe L α 214 X-ray line for quantification of Fe in olivines in the compositional range between Fo91 and Fo0. 215 They showed that it was possible to achieve very good results with relative deviations to the 216 expected Fe concentrations varying from 1 to 5%, at least for the olivines with FeO content ≥ 16 217 wt% (Buse and Kearns did not report quantification results using their method for olivines with 218 lower FeO content). Their proposed method is to reevaluate the MACs of the Fe L α X-ray line 219 by Fe in olivines at a given X-ray energy (or spectrometer position) as well as to evaluate partial 220 fluorescence enhancement factors. Both factors vary smoothly with respect to the Fe 221 concentration and can be interpolated using a regression fit. Thus, these coefficients can be used 222 in ZAF or phi-rho-z matrix correction algorithms to quantify Fe using traditional k-ratios. The 223 reference material (i.e. standard) they utilized for this approach was an Fo33 olivine from 224 Dabbahu Volcano (Ethiopia), provided by a researcher at their institution. However, because of

This is a preprint, the final version is subject to change, of the American Mineralogist (MSA)
Cite as Authors (Year) Title. American Mineralogist, in press.
DOI: https://doi.org/10.2138/am-2019-6865

225	the proximity of the Fe L_2 and L_3 absorption edges which lead to a rapid increase of the MAC
226	with increasing X-ray energy, determining these coefficients using the described method can
227	lead to close but different values of the MAC measured by different instruments/spectrometers
228	due to differences on the resolution of the spectrometers used. To apply their proposed method,
229	one will have to re-determine the MACs on their own instrument/spectrometers and a set of
230	olivines reference materials. In addition, matrix correction algorithms allowing the use of
231	different MAC values for the unknown and for the standard, in addition to the use of user-defined
232	partial fluorescence yields, are not broadly available yet, making it difficult to utilize this method
233	for routine applications.
234	
235	
236	MATERIALS AND METHODS
237	
238	Electron Probe Measurements
239	
	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron
240	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a
240 241	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University
240 241 242	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University of Minnesota using a JEOL JXA-8530FPlus electron microprobe. Both instruments used Probe
240241242243	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University of Minnesota using a JEOL JXA-8530FPlus electron microprobe. Both instruments used Probe for EPMA to collect the data (Donovan et al. 2018).
240241242243244	The spectra of the Fe Lα-Lβ X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University of Minnesota using a JEOL JXA-8530FPlus electron microprobe. Both instruments used Probe for EPMA to collect the data (Donovan et al. 2018). The JEOL JXA-8530FPlus is outfitted with the new Soft X-ray Spectrometer "SXES"
 240 241 242 243 244 245 	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University of Minnesota using a JEOL JXA-8530FPlus electron microprobe. Both instruments used Probe for EPMA to collect the data (Donovan et al. 2018). The JEOL JXA-8530FPlus is outfitted with the new Soft X-ray Spectrometer "SXES" that consists of an extended range diffraction grating JS2000, and a Peltier-cooled CCD camera
 240 241 242 243 244 245 246 	The spectra of the Fe L α -L β X-ray lines were measured at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, University of Wisconsin-Madison, using a CAMECA SXFiveFE electron microprobe, and at the Department of Earth Sciences, University of Minnesota using a JEOL JXA-8530FPlus electron microprobe. Both instruments used Probe for EPMA to collect the data (Donovan et al. 2018). The JEOL JXA-8530FPlus is outfitted with the new Soft X-ray Spectrometer "SXES" that consists of an extended range diffraction grating JS2000, and a Peltier-cooled CCD camera (Terauchi et al. 2011). This type of spectrometer acquires the whole spectrum between 240 and

- Three wavelength-dispersive spectrometers (WDS) were used to record the spectra on the SXFiveFE microprobe and two WDSs and the SXES were used on the JXA-8530FPlus microprobe (further details including monochromators used are given in Supplemental materials, Table I). All the spectrometers have a takeoff angle of 40°.
- 252

253 On the CAMECA instrument, 4 spectra covering the Fe L α -L β spectral range were 254 acquired on each sample and then averaged together. The spectra were measured at 7 kV and 90 255 nA, from 0.686 keV to 0.734 keV with 500 steps and a dwell time of 1.8 seconds/step for the 256 TAP crystals and 1.5 seconds/step for the PC0 pseudocrystal.

257 On the JEOL instrument, 3 spectra were accumulated for each sample with the WDS's 258 and only one spectrum was recorded with the SXES, as this last detector is much more counting-259 efficient than the WDS. With the WDSs, the spectra were recorded from 0.688 keV to 0.732 keV 260 with 500 steps and a dwell time of 2.4 seconds/step. With the SXES, the spectra were recorded 261 at 7 kV and 20 nA, from 0.236 to 2.830 keV with 4096 steps and a total counting time of 15 262 minutes. A 5 µm beam diameter was used for all the measurements on both electron microprobes. 263 The integrated areas of the spectra were calculated by numerical analysis using the 264 trapezoidal rule. For the spectra recorded with the SXES detector, the step size is relatively large 265 compared to the width of the X-ray lines. This implies a small underestimation of the calculated 266 area using this spectrometer. The small error resulting from this underestimation will be partially 267 cancelled out, and thus minimized, during the calculation of the area k-ratio as the Fe Lα-Lβ X-268 ray line shapes of the olivine samples and of the Fe standard are very similar. Before the 269 determination of the area integral, the background was fitted and removed using a linear curve

270 for the TAP crystals and the SXES, and using an exponential background for the PC0 crystal.

271	One concern that arises when measuring Fe in Fe-bearing materials using an electron
272	beam is the change of the oxidation state of Fe due to interactions with the incident electrons.
273	The change of Fe oxidation state under beam irradiation can lead to inaccuracies when measuring
274	the X-ray intensity at the peak maximum or can lead to distortion of the recorded spectrum and
275	it has been shown that the Fe peak position will shift toward the high energies when the oxidation
276	state changes from Fe^{2+} to Fe^{3+} (Fialin et al. 2011). In olivine, which contains almost exclusively
277	divalent Fe, such a change in the oxidation state is unlikely to occur but must be investigated
278	nevertheless. A recent paper by Li et al. (2019) reports a method to observe the change in Fe
279	oxidation by monitoring the variations of the X-ray intensity ratio FeL β /FeL α over time. We
280	have monitored the FeL α and FeL β X-ray intensities at 15 kV, 90 nA for 260 seconds with
281	measurements at 10 second intervals on synthetic fayalite, Wards fayalite and San Carlos olivine.
282	The measurements were repeated at least 3 times on different locations and then averaged. No
283	obvious change in the FeL β /FeL α ratio was observed (see Supplementary materials, Figure 1).
284	This indicates that the Fe oxidation state in olivine is not altered by the electron beam.

285

286 Olivines

A set of nine olivine samples was used in this study. The intermediate Fe range (Fo47-73) is covered by five olivines from (Aleutian) Shishaldin Volcano basalts (Fournelle 1988) and two olivines from the Smithsonian National Museum of Natural History: the Springwater olivine is from the microbeam standards collection (USNM 2566, Jarosewich et al. 1980) and the San Carlos is a "coarse" fraction from the same split as the USNM 111312/444 in the microbeam standards collection (T. Rose, pers. comm.). The synthetic fayalite source (Finch et al. 1980) was Jill Banfield. The Wards fayalite is a sample from Crystal Park, Colorado (Barker et al. 1975).

294 These olivines' iron elemental concentrations range from 7.64 wt% to 53.9 wt%. The 295 olivine samples were characterized by EPMA at 15 kV and 20 nA, using the traditional Ka X-296 ray lines, the PAP matrix correction algorithm (Pouchou and Pichoir 1991), and the MAC30 mass absorption coefficients (Heinrich 1987). At least 15 points were acquired to reduce the 297 298 statistical uncertainties. The instrument used to measure the composition was a CAMECA SX51 299 microprobe at the Eugene Cameron electron microscopy laboratory, Department of Geoscience, 300 University of Wisconsin-Madison, equipped with five WDSs. The details of the oxide 301 composition of each sample are given in Table I (and the corresponding stoichiometric formula 302 are given in Supplemental materials, Table II). As further results of this paper are given in 303 elemental wt%, those concentrations of Fe are also shown in Table I. Particular attention was 304 paid to select one homogeneous crystal (determined by BSE imaging and multiple EDS 305 measurements) from each sample, and to focus on the same area for both the 15 and the 7 kV 306 measurements.

307

308 Carbon contamination

To study and mitigate the effects of carbon contamination during spectra acquisition, a custom cryo-chiller replacing the liquid nitrogen dewar used to cool the CAMECA cold plate was used to perform the measurements on the CAMECA SXFiveFE instrument. This anticontamination device was able to decrease the temperature in the microprobe chamber to about -150°C and reduced the vacuum to as low as 8×10^{-7} Pa. In addition to freezing the volatile contaminants, the cryo-chiller also cooled the samples by radiative transfer, reducing the mobility of contaminants on the sample surface.

316 To study the effects of carbon contamination on the measurements, long spectrum 317 acquisitions (~19 minutes for each spectrum) were performed first by recording the spectrum 318 from low X-ray energies to high X-ray energies and then by repeating the measurements from 319 high to low X-ray energies on a new spot. Any significant amount of carbon contamination 320 deposited during spectrum acquisition should distort the spectrum by decreasing the electron 321 landing energy and increasing the absorption of the emitted X-rays. These effects, more 322 pronounced at the end of the acquisition than at the beginning, should result in different 323 appearances between the two spectra.

324 Spectrum acquisitions were performed on pure Fe, USNM Spring Water olivine, San 325 Carlos olivine, Wards fayalite and synthetic fayalite, covering the entire range of Fe 326 concentrations. The measurements were performed at 7 kV and 90 nA using three WDSs (LTAP, 327 TAP and PC0 monochromator crystals as described in Supplementary materials, Table I). X-328 rays were recorded with 100 steps and for photon energies ranging from 685.8 to 733.7 eV for 329 the LTAP crystal, from 684.8 to 732.7 eV for the TAP crystal, and from 582.5 to 892.3 eV for 330 the PC0 crystal. Three different spectra were measured on each sample and each direction and 331 averaged together (the averaged spectra are shown in Supplementary materials, Figure 2).

The spectra measured in both directions show no significant differences in peak shape or intensities on either the background or the tails of the peaks. The only noticeable differences are slightly less intense peak maxima for the L α line and more intense maxima for the L β line when the spectrum was recorded from high to low energies relative to the other direction. This difference is well explained by an increase of the carbon contamination thickness during acquisition. However, the differences between the spectra are typically within the uncertainties of the counting statistics associated with the measurements. The maximum relative standard

deviation (RSD) of the calculated areas of the Fe L α -L β X-ray lines between spectra measured in opposite directions was found to be 1.8% for the Spring Water olivine (low Fe concentration) when measured with the TAP crystal (low detection efficiency, large statistical fluctuations). Nevertheless, all data used to derive the calibration curves came from the spectra measured with increasing spectrometer positions, i.e. with decreasing photon energy (except for the SXES where this is not relevant) to be consistent.

345 The changes in peak area due to carbon contamination remain generally very small, with 346 mean RSD found to be 0.8%, 1.3% and 0.4% for the LTAP, TAP and PC0 monochromator 347 crystals, respectively. This indicates carbon contamination has no significant effect on the 348 measurements when using a cryo-chiller at these experimental conditions. No cold trap or other 349 anti-contamination devices were used in the JEOL JXA-8530FPlus instrument or, later, in the 350 CAMECA SX51 instrument. However, the obtained results (the area k-ratios) agree within the uncertainties with the results obtained on the CAMECA SXFiveFE instrument using the cryo-351 352 chiller. This indicates that even when no anticontamination devices are used, carbon 353 contamination effects are not significant enough to significantly affect the measurements.

354

355

RESULTS

356

357 We studied utilization of the Fe L α line for low kV EPMA in a set of olivines as well as 358 a set of iron silicides (Moy et al. 2019). An essential part of this involved attempting to determine 359 the Fe L α MACs, which lead to a reevaluation of the procedures used to measure them. This 360 reevaluation, going back to fundamental parameters, sheds light on why it is so difficult to 361 determine the correct MAC in the energy/wavelength region at the Fe L α peak position, which

362 lies across the Fe L_3 edge position.

All measured X-ray peaks are broader than they would appear naturally: their shapes are 363 364 considered to be Voigt profiles, convolutions of two broadening mechanisms, one being the 365 Lorentzian profile for the natural width of the peak, the other the Gaussian profile for the 366 broadening by the specific spectrometer being used (Rémond et al. 1993). However, direct 367 determination of the MAC of the Fe L α peak from an iron silicide or olivine was found to be 368 impossible. Any attempt to measure precisely the MAC at any single peak channel is not possible 369 because of the Gaussian broadening of the spectrometer and the rapidly changing MAC value 370 under the energy range of this Gaussian. Ultimately, if it were possible to correctly measure the 371 MACs for a range of iron-bearing phases, they would define a 3 dimensional plot, as functions 372 of both specific energy/wavelength as well as Fe content. A full explanation and theoretical 373 derivation proving the futility of determining MACs for Fe-bearing phases, using the traditional 374 EPMA approach (e.g., XMAC (Pouchou 1996)) is given in Moy et al. (2019).

375

376 Traditional quantification method with the Fe La X-ray line

To corroborate the need for an improved quantification method when using the Fe L α Xray line at 7 kV, we tried to quantify our set of olivines, previously characterized at 15 kV using the Fe K α X-ray line and varying primary standards: (1) the pure Fe standard as it was used to perform the quantification using the K α X-ray line, (2) the Wards fayalite standard as representative of commonly used Fe standards in EPMA for geological work, and (3) the SH111 standard as the one with the highest Fe abundance and a substantial amount of Mg in our set of olivines. The quantification results, performed using the PAP matrix correction algorithm

384 (Pouchou and Pichoir 1991) and the MAC30 MAC data table (Heinrich 1987), are very poor 385 (see Supplementary materials, Table III) and yield RSD of up to 60% compared to their nominal 386 Fe concentration, as seen in Figure 4. The only adequate results are obtained when the Fe 387 quantification of an olivine is performed using itself as a primary standard. These poor 388 quantification results can be attributed to changes of the atomic parameters (MAC and 389 fluorescence yield) between the different olivine and pure Fe samples. These parameters, in 390 addition to not being known precisely except for pure Fe, will differ between the quantified 391 olivine and the standard, and traditional matrix correction algorithms do not support different 392 atomic values for the unknown and the standard. It is also worth noting that the RSD increases 393 with increasing Fe content in the olivines at approximately the same rate, regardless of the 394 standard used. These results show that quantification of Fe in olivines with the La X-ray line 395 cannot be done using the traditional quantification method.

396

397 Plot of Fe Lα+Lβ k-ratio versus Fe content

398 After much time and effort evaluating the Fe L α -L β spectra of both iron silicides and 399 olivines, and realizing that there were insurmountable obstacles to determining the Fe L α MACs 400 correctly, another approach was called for. What to do? When in doubt, make a plot. And so, 401 combined-integrated k-ratios were determined: we integrated the areas under the Fe L α -L β 402 wavescan peaks and subtracted the backgrounds, for both the experimental samples and a pure 403 iron standard, and then created "area k-ratios" using the pure iron standard. When these 404 integrated Fe L α -L β wavescan area k-ratios were plotted against the sample Fe-content (Figure 405 5), a simple relationship became obvious (experimental k-ratios are given in Supplemental 406 materials, Table IV).

407	There is a strong degree of direct correlation between the integrated Fe L α +L β k-ratios					
408	and the Fe content of the olivines. The data can be fitted by a simple third order polynomial (with					
409	conditions of being 0 when the area k-ratio is 0 and being as close as possible to 100 when the					
410	area k-ratio is 1) with an R^2 value of 0.999.					
411						
412	This simple approach allows the X-ray intensity of the integrated Fe L α -L β peak to be					
413	used to quantify the iron content of olivines. We suggest it can be applied to any conventional					
414	electron microprobe; the only limitation is having a spectrometer takeoff angle of 40°, the					
415	accelerating voltage being 7 kV and the standard to calculate the k-ratio being pure Fe. It entails					
416	(a) the measurement of the area of Fe L α -L β spectrum of the olivines being studied, (b) the same					
417	measurement on a pure Fe metal standard (a common, easily available standard), and removing					
418	the backgrounds for both the olivine and the Fe metal standard, and (c) using the following					
419	calibration curve (equation (1)) to read out the Fe wt% of the olivine:					
420	(1) Fe wt. % = $81.718 \times K + 134.07 \times K^2 - 115.79 \times K^3$					
421	where K is the area Fe L α +L β k-ratio. This elemental Fe value would then be input into the					
422	matrix correction software as a defined element, with the other elements quantified using the					
423	traditional matrix correction.					
424						
425						
426	DISCUSSION					
427						
428	Theoretical derivation of area k-ratio					

Why would this apparently simple calibration curve work, and we assert, work on any electron microprobe? To understand this, we enter the realm of the physics used to go from the raw X-ray intensities, via the so-called "matrix correction", to the final corrected element values. Most people delve as far as the so-called ZAF correction, which was a highly simplified expression needed when computing power was minimal. But it all rests upon a strong physical basis, the so-called fundamental equation of the microanalysis, which can be written as:

435

436 (2)
$$I_X(E_{ph}) = C_A \frac{N_a}{A_r} n_{el} \omega_i^A \Gamma_{ij}^A Q_i^A(E_0) \int_0^\infty \varphi_i(\rho z) e^{-\frac{\mu}{\rho}(E_{ph}) \frac{\rho z}{\sin \theta_d}} d\rho z \left[\varepsilon \frac{\Delta \Omega}{4\pi} \right] (E_{ph}) F \left(1 + g_{CK} \right)$$

437

where $I_X(E_{ph})$ is the number of characteristic X-rays of energy E_{ph} recorded per unit of time for 438 the X-ray line of interest, C_A is the concentration of the studied element A, N_a is the Avogadro 439 number and A_r is the atomic weight of element A. n_{el} is the number of primary electrons 440 reaching the sample per unit of time, ω_i^A is the fluorescence yield for the element A and a 441 442 primary ionization in the shell i (i.e., the probability of emitting a photon during relaxation of atom A with an initial vacancy in the electronic shell i). Γ_{ij}^A is the transition rate from shell j to i 443 444 (i.e., the probability that the relaxation occurs by the transition of an electron from the shell j to the vacancy located in shell i). $Q_i^A(E_0)$ is the ionization cross section (in cm²) of the shell i of 445 element A by impact of electrons with energy E_0 . $\varphi_i(\rho z)$ is the so-called phi-rho-z function 446 447 representing the depth distribution of ionization of electronic shell i of element A at mass depth 448 ρz inside the sample for an incident electron beam of energy E_0 . The next term in equation (2), 449 corresponding to the exponential factor, represents the attenuation of the created X-rays inside 450 the sample before they reach the surface with an angle θ_d corresponding of the takeoff angle of

the detector. $\frac{\mu}{\rho}(E_{ph})$ is the MAC (in cm²/g) of the sample for a photon of energy E_{ph} . ε and $\frac{\Delta\Omega}{4\pi}$ 451 are the intrinsic detection efficiency of the spectrometer for photons of energy E_{ph} and the 452 geometric detection efficiency of the spectrometer also for photons of energy E_{ph} , respectively. 453 F represents the secondary fluorescence enhancement factor (F ≥ 1) and the (1+g_{CK}) factor 454 455 represents the X-ray intensity enhancement by Coster-Kronig and super-Coster-Kronig effects. The X-ray intensity calculated by equation (2) corresponds to the intensity of a single 456 457 characteristic X-ray. In the case where several characteristic lines are considered, the total X-ray 458 intensity becomes the sum of the X-ray intensities of each of the considered lines, each intensity 459 being calculated using equation (2) with the appropriate atomic parameters. 460 This equation works well in the general case, but it assumes some simplifications that 461 can be problematic in certain circumstances. One drawback of this equation is the fact that the 462 characteristic X-ray is supposed to be emitted at an exact energy E_x . In reality, the X-ray line has 463 a natural width (also called natural broadening) following a Lorentzian shape for the inner shell 464 transitions and with its maximum centered on E_x. 465 In addition, the spectrometer response function must also be taken into account. This 466 function depends on the X-ray energy recorded (E_{ph}) . In the case of crystal monochromators, 467 because of crystal imperfections such as mosaic misorientation (Bertin, 1975), the detector 468 response function will not be a Dirac (delta) function following Bragg's law, i.e., not only the 469 wavelength satisfying $n\lambda = 2d \sin(\theta)$ will be reflected. Instead, wavelengths of radiation 470 length $\lambda + d\lambda$ will also be reflected but with a reduced intensity, which decreases rapidly as $d\lambda$ 471 increases. The detector response function can be well described by a Gaussian function centered 472 on the recorded wavelength λ_X (or on the recorded energy E_x in an energy representation) and all the photons in a range $[E_{ph}-3\Gamma_G; E_{ph}+3\Gamma_G]$ are appreciably reflected by the crystal, with an intensity proportional to the Gaussian function. With traditional WDS, the X-rays are usually detected by a flow gas detector or by a sealed gas detector. The response function of this detector is usually represented by an integrator: all the photons reaching the detector are detected, without discrimination of their energy. An energy window can be used to discriminate high order X-ray reflections (corresponding to higher energies) but cannot distinguish photons in an energy range as small as $[E_{ph}-3\Gamma_G; E_{ph}+3\Gamma_G]$.

481 The natural spectrum, i.e. the spectrum emitted from the sample before detection, is 482 described by the product of the emitted intensities I_x with the area-normalized Lorentzian 483 functions. The recorded spectrum is then the convolution of the natural spectrum with the 484 spectrometer response function. More details are given in Moy et al. (2019). When Ix is not dependent on the X-ray energy, i.e. when $\left[\varepsilon \frac{\Delta \Omega}{4\pi}\right] (E_{ph})$ and $\frac{\mu}{\rho} (E_{ph})$ are constant over the X-ray 485 486 energy range effectively recorded by the spectrometer due to its instrumental broadening (typically from E_{ph} -3 Γ_{G} to E_{ph} +3 Γ_{G}), the X-ray intensity can be extracted from the previously 487 488 mentioned convolution product. Consequently, by normalizing the unknown intensity with an 489 intensity recorded on a standard sample, and assuming that the natural broadening of the X-ray 490 line and the spectrometer broadening are the same for both the unknown and the standard, the 491 remaining convolution product will be the same for the unknown and the standard and will cancel 492 out during the calculation of the so-called k-ratio. One can then obtain the k-ratio traditionally 493 used to perform quantitative EPMA.

494 However, in the case of the Fe L α and L β X-ray lines, the MAC changes rapidly over 495 the spectrometer broadening energy range because of the nearby presence of the L₂ and L₃ 496 absorption edges (and can additionally vary due to different compositions and bonding

497 environments between the standard and the unknown), and so the X-ray intensity, I_X , cannot be 498 extracted from the above-mentioned convolution—which is what is typically done in "normal 499 EPMA". The broadening effects now do not cancel out and so the measured k-ratio still depends 500 on the spectrometer broadening, i.e. of the instrument used, and hence will not be suitable for a 501 universal ZAF or phi-rho-Z matrix correction.

Fortunately, by integrating the intensity of the X-ray lines of interest over the whole energy range – theoretically from $-\infty$ to $+\infty$, but in practice over the energy range of the Fe Lα-Lβ spectrum where the characteristic X-ray intensity is not negligible – the integral of the convolution product can be separated into the product of two integrals:

506

507 (3)
$$\int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} I_X(E) L(E) G\left(E - E_{ph}\right) dE dE_{ph} = \int_{-\infty}^{+\infty} I_X(E) L(E) dE \int_{-\infty}^{+\infty} G(E) dE$$

508

509 where L(E) and G(E) represent the Lorentzian (the natural broadening) and Gaussian (specific 510 detector broadening) contributions to the spectrum, respectively. Notice that when several X-ray 511 lines are considered, L(E) is replaced by a sum of Lorentzian functions corresponding to the 512 different transitions, such as the Fe L α_1 , Fe L α_2 and Fe L β_1 X-ray lines, at the condition that 513 $I_{x}(E)$ is also replaced by a sum of X-ray intensities, each corresponding to the different 514 transitions taken into account and each being calculated by means of equation (2) using the 515 appropriate atomic parameters. Other transitions, far from those of interest, can be disregarded 516 as we only calculate the area for the Fe L α -L β X-ray lines and they are not interfering with these lines of interest. 517

519 By calculating the k-ratios using the area of the X-ray lines (noted kr_{Area}), where the 520 superscript *u* is for the unknown and *s* is for the standard, we obtain:

521

522 (4)
$$kr_{Area} = \frac{\int_{-\infty}^{+\infty} I_X^u(E)L(E)dE \int_{-\infty}^{+\infty} G(E)dE}{\int_{-\infty}^{+\infty} I_X^s(E)L(E)dE \int_{-\infty}^{+\infty} G(E)dE} = \frac{\int_{-\infty}^{+\infty} I_X^u(E)L(E)dE}{\int_{-\infty}^{+\infty} I_X^s(E)L(E)dE}$$

523

The k-ratio in equation 4 is now independent of the spectrometer broadening and hence suitable for the creation of a universal calibration curve. The only limitation that remains is that the takeoff angle of the detector (included in the term I_X) must be of 40°, as is the case for most of the commercially available electron microprobes today (in particular the JEOL and CAMECA instruments used in this study).

529

530 Calibration Curve using the Lα-Lβ Area

531 The integrated areas of the Fe L α -L β spectra measured on each olivine sample were 532 normalized to the area integral obtained on the pure Fe standard (area k-ratio) and plotted as a 533 function of the Fe concentration, shown previously in Figure 5.

The experimental data follow a smooth increase with increasing Fe concentration. We found that values are very similar from one spectrometer to another, independent of the spectrometer used, and in agreement with the theoretical treatment. Therefore, data across instruments and spectrometers were averaged subsequently. The averaged data was fitted by a third order polynomial under the physical conditions that the Fe concentration is equal to 0 when the area k-ratio value is 0 and equal to 1 when the area k-ratio value is 1. As shown in Figure 6, the resulting fit is very good with a with a regression factor of 0.999. While the data measured

- on the SH111 and Wards fayalite olivine samples have the highest RSD, the values still agreewith the fitting curve within the statistical uncertainties.
- 543
- 544
- 545
- 546

547 **Testing the Calibration Curve**

The quantification of olivines based on this new approach follows a two-step process: first the Fe concentration is determined with the area k-ratio calibration curve using Fe metal as a standard and then, fixing this Fe value in the matrix correction, the other elements are quantified using the traditional method with measured k-ratios.

552 The calibration curve was tested again on a subset of our olivine samples, but using 553 different grains and using a different electron microprobe (CAMECA SX51 at the University of 554 Wisconsin-Madison) and some additional olivines with good results. Each olivine grain was 555 quantified again at 15 kV using the traditional Fe Ka X-ray lines prior to spectra acquisition to 556 account for any inter-grain compositional variability. Three WDSs were tested: two TAP crystals 557 (2d = 25.745 Å) and a PC0 crystal (2d = 45.0 Å). Comparisons of the nominal Fe concentrations 558 measured at 15 kV with the Fe concentrations measured at 7 kV using the calibration curve are 559 given in Table II and shown on Figure 7.

560

Very good results are obtained with the PC0 crystal with almost all the samples with the exception of the Rockport fayalite where Fe was underestimated by 2.28 wt%. Both TAP crystals gave reasonably good results for almost all the samples but also highly underestimate the Fe

564 concentration of the Rockport fayalite. This may indicate a problem with (1) the nominal 565 composition of this sample (even if it has been re-acquired prior to the measurement, the spectra 566 were acquired at close but different positions and local heterogeneities on the fayalite (Rose et 567 al. 2009) can explain the seen deviations), (2) a tilt of the sample or sample holder, changing the 568 takeoff angle, or (3) a problem with the calibration curve itself. The latter seems unlikely to be 569 the explanation as for the PC0 crystal, the Fe composition of the Rockport favalite samples are 570 well reproduced and the calibration curve varies smoothly everywhere. The spectrometer number 571 2 underestimated the Fe concentration in general, which can be attributed to its relatively low X-572 ray intensity yield (lower than for the two other spectrometers) making the recorded spectra 573 noisier and therefore, making the background removal less accurate. An overestimation of the 574 background leads to an underestimation of the peak area and then to an underestimation of the 575 Fe concentration.

576

577 In addition, the calibration curve was also tested on a different set of olivines using the 578 CAMECA SXFiveFE instrument, following the same experimental protocol and the obtained Fe 579 concentration, in wt%, are given in Table III and plotted in Figure 8. The k-ratio versus nominal 580 Fe concentration curve acquired on these samples is in very good agreement with the previously 581 acquired calibration curve. Hence, the Fe concentrations determined using the calibration curve 582 (Eq. 1) are also in good agreement with the expected concentration, as shown in Table III. Again, 583 the determined Fe concentration for the fayalite samples is underestimated especially for the 584 spectrometer number 2 which has the lowest detection efficiency. Except this deviation, other 585 results are in very good agreement with the expected Fe concentrations, demonstrating the 586 robustness of this analytical approach irrespective of instrument, spectrometer and crystal 587 choices. It is worth noting that the area calibration curve is also robust against the spectrometer 588 energy drift (change of the maximum peak position over time) as the entire spectrum is recorded 589 and integrated.

590

591 Calibration Curve using the maximum intensity of the La X-ray line

592 The drawback of the area intensity method is the long acquisition time for each spectrum. 593 The combination of the calibration curve approach with traditional k-ratios was tested as a means to shorten acquisition times. Intensity measurements using the SXFiveFE and SX51 instruments 594 595 were acquired on the olivine samples at the maximum intensity of the Fe L α X-ray line and on each side of the Fe L α -L β peaks (at 0.686 keV and 0.733 keV for the LTAP and TAP crystals 596 597 and at 0.583 keV and 0.830 keV for the PC0 crystal) to subtract the background. The X-ray 598 intensity was also measured on the pure Fe standard and a traditional k-ratio was calculated. 599 When plotted against the Fe concentration, similarly to what has been obtained in the simpler 600 case of the Fe K α line by Keil and Fredriksson (1964), the k-ratios follow a smooth curve that 601 can easily be fitted by a third order polynomial as seen on Figure 9. However, when the Fe 602 concentration is plotted as a function of the experimental k-ratio, we were not able to obtain a 603 satisfactory fit using established mathematical functions. The previously found third order 604 polynomial cannot be inverted and used for practical application as it has two complex roots. 605 With the help of a spreadsheet program, the fitting polynomial can easily be evaluated and 606 tabulated for a large number of Fe concentrations, ranging from 0 to 100 wt%, with a small given 607 step (e.g., 0.5 Fe wt%). The unknown k-ratio and the corresponding Fe concentration can then 608 be obtained by linear interpolation of the closest values found in the spreadsheet. The obtained

In agreement with the theory discussed in section "Theoretical derivation of area k-ratio", these k-ratios are still dependent on the spectrometer efficiency. Hence, the obtained calibration curves are different for each spectrometer as shown on Figures 9a and 9b. However, the two spectrometers, Sp1 (LTAP or TAP crystal) and Sp2 (TAP crystal), give almost the same fitting curve as their instrumental broadening is very similar.

617

618 These "non-universal" calibration curves were obtained on the SXFiveFE and the SX51 619 instruments. On the SXFiveFE microprobe, the curves were deduced from measurements 620 performed on the two sets of olivine previously described in this paper. Only the first set of 621 olivines was used to derive the curve on the SX51 instrument. The measurements were 622 performed at 7 kV and 90 nA. The obtained curves were then used to re-quantify the Fe 623 concentration in the olivines. The results, shown in Table IV and V, give satisfactory quantitation 624 numbers. The highest average absolute deviation is seen for the synthetic fayalite samples where 625 the predictions underestimate the nominal values up to 2.42 wt%. The determination of this peak 626 maximum calibration curve, despite its "non-universal' character, is easier and less time 627 consuming than the calibration curve obtained using the peak area. The only drawback is that it 628 requires a calibration curve to be acquired for each spectrometer. The calibration curve gives 629 good quantification results especially when using the high-counting rate PC0 crystal even despite 630 the overlap with both the Fe L β X-ray line and the L₃ absorption edge.

031	It is of historical interest that Castaing, the father of EPMA, proposed in his landmark
632	1952 thesis (English translation in 1955) a simple version of what we show here: an "alpha
633	correction factor" for simple binary compounds, which was developed in more practical detail a
634	decade later by Ziebold and Ogilvie (1963) and ultimately into the Bence and Albee (1968)
635	correction factors for geological materials.
636	This method is more convenient to use than the area k-ratio method, but it gives slightly
637	less accurate quantitative results. The mean RSD (in absolute value and in percent) of the Fe data
638	obtained on the SXFiveFE instrument is 1.58% and 2.63% when using the area k-ratio calibration
639	curve and the peak maximum k-ratio calibration curve, respectively. The mean RSD for the
640	SX51 instrument is almost identical for both methods (3.60% and 3.61% using the area k-ratio
641	and peak maximum k-ratio calibration curves, respectively). The compromise in accuracy
642	relative to the speed of acquisition may be acceptable for certain applications
•	relative to the speed of acquisition may be acceptable for certain appreations.
643	Teluive to the speed of dequisition may be deceptione for certain appreations.
643 644	
643644645	Tendive to the speed of dequisition may be deceptione for certain appreations.
643644645646	IMPLICATIONS
 643 644 645 646 647 	IMPLICATIONS
 643 644 645 646 647 648 	IMPLICATIONS The discovery that a simple calibration curve approach, employing the relatively high
 643 644 645 646 647 648 649 	$\label{eq:interval} \textbf{IMPLICATIONS}$ The discovery that a simple calibration curve approach, employing the relatively high intensity Fe L\alpha and L\beta peak integrals, can be used as a platform-independent tool for low kV
 643 644 645 646 647 648 649 650 	IMPLICATIONS The discovery that a simple calibration curve approach, employing the relatively high intensity Fe L α and L β peak integrals, can be used as a platform-independent tool for low kV quantitative analysis is significant. It provides an easy-to-use method to quantify the iron L X-
 643 644 645 646 647 648 649 650 651 	IMPLICATIONS The discovery that a simple calibration curve approach, employing the relatively high intensity Fe L α and L β peak integrals, can be used as a platform-independent tool for low kV quantitative analysis is significant. It provides an easy-to-use method to quantify the iron L X-ray signal by applying a universal equation and utilizing an easily available standard material

653 recommend averaging of 2 or 3), is balanced by the significantly higher count rates relative to 654 those of the Fe L ℓ line, thereby reducing the analytical statistical error.

655 While applying the calibration curve approach to only the net Fe L α peak maximum 656 intensities improves ease and speed of acquisition, it requires re-evaluating the calibration curve 657 for each spectrometer and requires having a set of olivine samples of known composition with 658 Fe content covering the concentration range of interest.

Our technique is particularly suited to high spectral resolution, parallel channel X-ray detectors such as the SXES as they acquire the entire Fe L X-ray spectrum simultaneously. While their presence in laboratories is currently very sparse, they could play a more important role in the future, particularly for geoscientists.

Future lines of research may include investigating the robustness of the calibration curve approach at different accelerating voltages (e.g. 3, 5, and 10 kV) and different spectrometer takeoff angles. In addition, the exploration of other iron-rich systems (minerals and glasses) could determine whether their Fe L α +L β area k-ratio might fall on the same curve, or different curves, or have no correlation with composition.

It may also be of interest to try to obtain the same calibration curve with an EDS as it should work if the takeoff angle is 40° and would expand the applicability of this quantification method to a wider audience.

671

672

673

ACKNOWLEDGMENTS

674

675 We thank the following for providing a second set of olivines for testing the calibration curve:

676	Noriko Kita, Mike Spicuzza, Kohei Fukuda. The authors would like to thank the two reviewers
677	for their detailed comments which helped make the manuscript more complete. Support for this
678	research came from the National Science Foundation: EAR13-37156 (JHF), EAR15-54269
679	(JHF) and EAR-1625422 (AVDH).
680	
681	REFERENCES
682	
683	Anderson, C.A. (1967) The quality of x-ray microanalysis in the ultra-soft x-ray region. British
684	Journal of Applied Physics, 18, 1033-1043.
685	
686	Anderson, C.A., and Hasler, M.F. (1966) Extension of electron microprobe techniques to
687	biochemistry by the use of long wavelength X-rays. In R. Castaing, P. Deschamps and J.
688	Philibert, Eds., Proceedings of the Fourth International Conference on X-ray Optics and
689	Microanalysis, p. 310-327. Hermann, Paris.
690	
691	Barker, F., Wones, D.R., Sharp, W.N., and Desborough, G. A. (1975) The Pikes Peak
692	batholith, Colorado Front Range, and a model for the origin of the gabbro-anorthosite-
693	syenite—potassic granite suite. Precambrian Research, 2 (2), 97-160.
694	
695	Barkshire, I., Karduck, P., Rehbach, W.P., and Richter, S. (2000) High-spatial-resolution low-
696	energy electron beam X-ray microanalysis. Microchimica Acta, 132 (2-4), 113-128.
697	
698	Bertin, E.P. (1975) Principles and Practice of X-Ray Spectrometric Analysis, 1079 p. Plenum
699	Press, New York.

- 701 Buse, B., and Kearns, S. (2015) Importance of carbon contamination in high-resolution (FEG)
- 702 EPMA of silicate minerals. Microscopy and Microanalysis. 21, 594-605.
- 703 doi:10.1017/S1431927615000288
- 704
- 705 Buse, B., and Kearns, S. (2018) Quantification of Olivine Using Fe Lα in Electron Probe
- 706 Microanalysis (EPMA). Microscopy and Microanalysis. 24, 1–7. doi:
- 707 10.1017/S1431927618000041
- 708
- 709 Castaing, R. (1952) Application des sondes électroniques à une méthode d'analyse ponctuelle
- 710 chimique et cristallographique. Ph.D. thesis, Université de Paris, France. (Publication ONERA
- 711 no. 55)
- 712
- 713 Castaing, R. (1955) Application of Electron Probes to Local Chemical and Crystallographic
- 714 Analysis (Application des sondes électroniques à une méthode d'analyse ponctuelle chimique
- 715 et cristallographique). Translation by Pol Duwez and David B. Wittry, California Institute of
- 716 Technology. (download http://www.microprobe.org/history/Castaing-Thesis-
- 717 clearscan.pdf/view)
- 718
- 719 Castaing, R. (1960) Electron Probe Microanalysis. In M. Marton, Ed., Advances in Electronics
- and Electron Physics, p. 317-386. Academic Press Inc., New York and London.
- 721

- 722 Castaing, R., and Fredriksson, K. (1958) Analyses of cosmic spherules with an X-ray
- 723 microanalyser. Geochimica et Cosmochimica Acta, 14, 114-117.
- 724
- 725 Donovan, J., Kremser, D., Fournelle, J., and Goemann, K. (2018). Probe for Windows User's
- 726 Guide and Reference, Enterprise Edition, Probe Software, Inc., Eugene, OR.
- 727
- 728 Duncumb, P. (1960) Improved resolution with X-ray scanning microanalyser. In A. Engstrom,
- V. Cosslett, and H. Pattee, Eds., X-ray Microscopy and X-ray Microanalysis, Proceedings of
- 730 2nd International Symposium, p. 365-371. Elsevier, Amsterdam.
- 731
- 732 Fialin, M., Wagner, C., and Pascal, M.-L. (2011) Iron speciation using electron microprobe
- techniques: application to glassy melt pockets within a spinel lherzolite xenolith. Mineralogical
- 734 Magazine, 75, 347–362.
- 735
- Finch, C.B., Clark, G.W., and Kopp, O.C. (1980) Czochralski growth of single-crystal fayalite
- under controlled oxygen fugacity conditions. American Mineralogist, 65, 381–389.
- 738
- 739 Fournelle, J.H. (1988) The Geology and Petrology of Shishaldin Volcano, Unimak Island,
- 740 Aleutian Islands; Ph.D. Thesis, The Johns Hopkins University, Baltimore.
- 741
- 742 Fournelle, J.H., Kim, S., and Perepezko, J.H. (2005) Monte Carlo simulation of Nb Kα
- secondary fluorescence in EPMA: comparison of PENELOPE simulations with experimental
- results. Surface and Interface Analysis, 37, 1012-1016.

/45	
746	Fournelle, J., Cathey, H., Pinard, P.T., and Richter, S. (2016) Low voltage EPMA: experiments
747	on a new frontier in microanalysis - analytical lateral resolution. In IOP Conference Series:
748	Materials Science and Engineering, 109, 1, p. 012003. IOP Publishing.
749	
750	Gopon, P., Fournelle, J., Sobol, P.E., and Llovet, X. (2013) Low-Voltage Electron-Probe
751	Microanalysis of Fe-Si Compounds Using Soft X-Rays. Microscopy and Microanalysis, 19,
752	1698-1708.
753	
754	Heinrich, K.F.J. (1987) Mass absorption coefficients for electron probe microanalysis. In J.D.
755	Brown and R.H. Packwood, Eds., Proceedings of the 11th international congress on X-ray
756	optics and microanalysis, p. 67–119. University of Western Ontario Press, London, Ontario.
757	
758	Höfer, H.E., Brey, G.P., Schulz-Dobrick, B., and Oberhansli, R. (1994) The determination of
759	the oxidation state of iron by the electron microprobe. European Journal of Mineralogy, 6, 407-
760	418.
761	
762	Hovington, P., Drouin, D., and Gauvin, R. (1997a) CASINO: A new Monte Carlo code in C
763	language for electron beam interaction-Part I: Description of the program. Scanning, 19, 1-
764	14.
765	

	201. https://doi.org/10.2100/dil/2010-0000
766	Hovington, P., Drouin, D., Gauvin, R., and Joy, D.C. (1997b) Parameterization of the range of
767	electrons at low energy using the CASINO Monte Carlo program. Microscopy and
768	Microanalysis, 3, 885-886.
769	
770	International Organization for Standardization (2003) Microbeam analysis — Electron probe
771	microanalysis — Guidelines for the determination of experimental parameters for wavelength
772	dispersive spectroscopy (ISO 14594).
773	
774	Jarosewich, E., Nelen, J.A., and Norberg, J.A. (1980) Reference samples for electron
775	microprobe analysis. Geostandards Newsletter, 4(1), 43-47.
776	
777	Kearns, S., Buse, B., and Wade, J. (2014) Mitigating thermal beam damage with metallic coats
778	in low voltage FEG-EPMA of geological materials. Microscopy and Microanalysis, 20(S3),
779	740-741.
780	
781	Keil, K., and Fredriksson, K. (1964) The iron, magnesium, and calcium distribution in
782	coexisting olivines and rhombic pyroxenes of chondrites. Journal of Geophysical Research,
783	69(16), 3487-3515.
784	
785	Li, X., Zhang, C., Almeev, R.R., Zhang, XC., Zhao, XF., Wang, LX., Koepke, J., and
786	Holtz, F. (2019) Electron probe microanalysis of Fe ²⁺ / Σ Fe ratios in calcic and sodic-calcic
787	amphibole and biotite using the flank method. Chemical Geology, 509, 152-162.

- 789 Libourel, G., and Portail, M. (2018) Chondrules as direct thermochemical sensors of solar
- protoplanetary disk gas. Science advances, 4(7), p.eaar3321.
- 791
- 792 Llovet, X., and Galan, G. (2003) Correction of secondary X-ray fluorescence near grain
- boundaries in electron microprobe analysis: Application to thermobarometry of spinel
- 794 lherzolites. American Mineralogist, 88, 121-130.
- 795
- Llovet, X., and Merlet, C. (2010) Electron Probe Microanalysis of Thin Films and Multilayers
- 797 Using the Computer Program XFILM. Microscopy and Microanalysis, 16, 21-32.
- 798
- 799 Llovet, X., and Salvat, F. (2016) PENEPMA: a Monte Carlo programme for the simulation of
- 800 X-ray emission in EPMA. In IOP Conference Series: Materials Science and Engineering, 109,
- 801 1, p. 012009. IOP Publishing.
- 802
- 803 Llovet, X., Heikinheimo, E., Galindo, A.N., Merlet, C., Bello, J.A., Richter, S., Fournelle, J.,
- and Van Hoek, C.J.G. (2012) An inter-laboratory comparison of EPMA analysis of alloy steel
- at low voltage. In IOP Conference Series: Materials Science and Engineering, 32, 1, p. 012014.
- 806 IOP Publishing.
- 807
- 808 Llovet, X., Pinard, P.T., Heikinheimo, E., Louhenkilpi, S., and Richter, S. (2016) Electron
- 809 probe microanalysis of Ni silicides using Ni-L X-ray lines. Microscopy and Microanalysis, 22,
- 810 1233-1243.
- 811

812	McSwiggen, P.	(2014)	Characterisation	of sub-micror	netre features	with the	FE-EPMA.	In IOI
012	10000155011, 1 .	(2011)	Characteribation	or sub mileron	field features			mito

- 813 Conference Series: Materials Science and Engineering, 55, 1, p. 012009. IOP Publishing.
- 814
- 815 Merlet, C., and Llovet, X. (2012) Uncertainty and capability of quantitative EPMA at low
- 816 voltage A review. In IOP Conference Series: Materials Science and Engineering, 32, 1, p.
- 817 012016. IOP Publishing.

- 819 Moy, A., Fournelle, J.H., and von der Handt, A. (2019) Quantitative measurement of iron-
- silicides by EPMA using the Fe L α and L β X-ray lines: a new twist to an old approach.
- 821 Microscopy and Microanalysis, in press. doi: 10.1017/S1431927619000436.

822

- 823 Pinard, P.T., and Richter, S. (2016) Quantification of low concentration elements using soft X-
- rays at high spatial resolution. In IOP Conference Series: Materials Science and Engineering,
- 825 109, 1, p. 012013. IOP Publishing
- 826
- Pouchou, J.L. (1996) Use of soft X-rays in microanalysis. Mikrochimica Acta 13(Suppl), 39–
 60.
- 829
- 830 Pouchou, J.L., and Pichoir, F. (1991) Quantitative analysis of homogeneous or stratified
- 831 microvolumes applying the model "PAP", In K. F. J. Heinrich and D. E. Newbury, Eds.,
- 832 Electron Probe Quantitation, p. 31-75. Plenum Press, New York.

- Reed, S.J.B. (1966) Spatial resolution in electron probe microanalysis. In R. Castaing, P.
- 835 Deschamps and J. Philibert, Eds., Proceedings of the Fourth International Conference on X-ray
- 836 Optics and Microanalysis, p. 339-349. Hermann, Paris.
- 837
- 838 Reed, S.J.B. (1975) Electron Microprobe Analysis. Cambridge University Press, Cambridge.
- 839
- Ritchie, N.W. (2011) Getting Started with NIST DTSA-II. Microscopy Today, 19(1), 26-31.
 841
- 842 Rose, T. R., Sorensen, S.S., and Post, J.E. (2009) The impurities in the Rockport fayalite
- 843 microbeam standard: How bad are they? American Geophysical Union, Fall Meeting 2009,
- 844 abstract id. V31E-2008.
- 845
- 846 Salvat, F., Fernandez Varea, J.M., and Sempau, J. (2013) PENELOPE A code system for
- 847 Monte Carlo Simulation of Electron and Photon Transport. OECD/Nuclear Energy Agency,
- 848 Issy-les-Moulineaux, France.
- 849
- 850 Saunders, K., Buse, B., Kilburn, M.R., Kearns, S., and Blundy, J. (2014) Nanoscale

characterisation of crystal zoning. Chemical Geology, 364, 20-32.

- 852
- 853 Shea, T., Lynn, K.J., and Garcia, M.O. (2015) Cracking the olivine zoning code:
- Distinguishing between crystal growth and diffusion. Geology, 43, 935–938. doi:
- 855 10.1130/G37082.1.
- 856

- 857 Terauchi, M., and Sato, Y. (2018) Chemical State Analyses by Soft X-ray Emission
- 858 Spectroscopy. JEOL NEWS, 53(1), 30-35.
- 859
- 860 Terauchi, M., Takahashi, H., Handa, N., Murano, T., Koike, M., Kawachi, T., Imazono, T.,
- 861 Hasagawa, N., Koeda, M., Nagano, T., and Sasai, H. (2011) An extension up to 4 keV by a
- 862 newly developed multilayer-coated grating for TEM-SXES spectrometer. Microscopy and
- 863 Microanalysis, 17(S2), 604-605.
- 864
- 865 Vladár, A.E., and Postek, M.T. (2009) The Scanning Electron Microscope. In J. Orloff, Ed.,
- Handbook of Charged Particle Optics, 2nd ed., p. 437-496. CRC Press.
- 867
- 868 Zschornack, G.H. (2007) Handbook of X-Ray Data. Springer-Verlag, Berlin.
- 869
- 870

871 Figure captions

Figure 1. (a) SE image of an 800 nanometer iron oxide crystal in K409 silicate glass. A profile
is drawn across a crystal edge to calculate the "edge resolution" based on the change in signal
intensity.

(b) Edge resolution, determined by fitting the signal intensity profile with an error function.

- 876 Depending upon the preferred convention of the degree of relative intensity change, various
- 877 beam diameters may be calculated.

878



880 Fo80 olivine, with both 15 kV W-filament (210 nm diameter, left) and FE beam (35 nm diameter,

right). Beam diameter values for 20 nA beam currents use estimates given in McSwiggen (2014)

and Pinard and Richter (2016). Outer contour shows the bounding perimeter where generation

of Mg Kα X-rays drops to 1% of the maximum generated intensity; internal contours are for

884 10%, 20%, 30% ... Mg Kα X-ray generation. Matrix absorption effect on the generated Mg Kα

885 X-rays is not included.

886

Figure 3. PENEPMA simulated vertical cross sections for Mg Kα X-rays generated at depth in

888 Fo80 olivine, with both 7 kV W-filament (210 nm diameter, left) and FE beam (35 nm diameter,

889 right). Both FE and tungsten sources show much reduced zones of Mg Kα X-ray generation

890 with depth compared to the 15 kV simulations (Figure 2). Note: these are models of X-ray

891 generation and do not take into account matrix absorption.

893	Figure 4. Quantification of the first set of olivine samples using the traditional quantification
894	method and the Fe La X-ray line at 7 kV. Three Fe standards were used to perform the
895	quantification. Regardless of the standard used, large deviations from the nominal Fe
896	concentration are observed.
897	
898	Figure 5. Integrated Fe L α +L β k-ratios acquired at 7 kV on two different instruments with six
899	different spectrometers. The olivine peak area measurements were normalized to the peak area
900	value obtained on the pure Fe standard.
901	
902	Figure 6. Calibration curve obtained by measuring the Fe L α and L β spectra at 7 kV on all
903	olivine samples and averaging the results. The area k-ratio has been obtained relative to the pure
904	Fe sample by integrating the Fe L α -L β spectrum (area method). (Error bars representing the
905	standard deviation of the experimental data are also plotted).
906	
907	Figure 7. Quantification of the first set of olivine samples using the calibration curve (Eq. 1)
908	determined at 7 kV. The measurements were performed on the SX51 instrument using three
909	different WDSs.

910

Figure 8. Quantification of a second set of olivine samples using the calibration curve (Eq. 1) at
7 kV. The measurements were performed on the SXFiveFE microprobe with three different
WDSs.

- 915 **Figure 9.** Calibration curves based on the maximum net peak intensity of the Fe Lα X-ray line
- 916 acquired with the SXFiveFE (a) and SX51 (b) microprobes. The curves obtained for the LTAP
- 917 (continuous line) and TAP (dashed line) crystals are very similar.

920 Footnote

- ¹ The physical terms kV and keV are used here in the strict sense: kV refers to an electrical
- 922 potential (as between the cathode and anode of the source), whereas keV refers to an energy of
- 923 a "particle" such as an electron or photon.

925 Tables

926 **Table I.** Oxide composition (wt%) of olivines, measured at 15 kV using the traditional K α lines 927 with the CAMECA SX51 instrument. The elemental Fe concentration is also given in the last 928 column. Numbers in parenthesis are the estimated standard deviations (uncertainties on the last

929 digits).

	SiO ₂	FeO	MnO	MgO	CaO	Total	Fe
	(wt%)	(wt%)	(wt%)	(wt%)	(wt%)	(wt%)	(wt%)
Synthetic Fayalite	28.79(13)	69.35(48)	0.20(4)	0.02(1)	0.00(2)	98.36(50)	53.90(31)
Wards Fayalite	29.31(19)	64.89(60)	4.49(38)	0.50(7)	0.09(4)	99.29(74)	50.44(30)
SH111	34.44(15)	41.93(43)	0.86(5)	21.10(11)	0.22(1)	98.55(47)	32.59(24)
SH11	34.96(25)	38.80(55)	0.86(5)	24.26(22)	0.26(2)	99.15(64)	30.16(24)
SH25	36.34(24)	33.89(98)	0.69(6)	28.66(73)	0.25(3)	99.83(1.25)	26.34(22)
SH9	37.49(20)	27.33(35)	0.57(5)	34.21(28)	0.18(1)	99.78(49)	21.25(20)
SH15	38.77(28)	23.98(39)	0.38(3)	38.09(30)	0.19(2)	101.41(56)	18.64(19)
USNM Springwater	39.82(20)	16.90(2)	0.32(11)	43.64(2)	0.02(17)	100.70(29)	13.14(16)
USNM San Carlos	40.95(25)	9.62(23)	0.14(4)	48.93(28)	0.10(2)	100.10(44)	7.64(12)

930

- 932 **Table II.** Re-quantification of the first set of olivine samples with the area k-ratio calibration
- 933 curve using different positions and different grains. The measurements where performed at 7 kV
- and 90 nA with the SX51 microprobe using three different WDSs. Numbers in parenthesis are
- 935 the estimated standard deviations (uncertainties on the last digits).

Sample name	Fe concentration (wt%)					
1	Nominal	Sp1 (TAP)	Sp2 (TAP)	SP4 (PC0)		
Coarse San Carlos Mnt 61	7.75(12)	7.46	7.38	7.17		
SH15 small Fo88.3 Mnt						
62	9.57(41)	7.99	7.71	8.30		
USNM Springwater #2	13.20(7)	12.95	13.02	13.19		
USNM Springwater #1	13.22(19)	12.72	13.21	13.16		
SH15 Big Fo72.7 Mnt 62	19.01(12)	17.08	15.7	18.28		
SH11 #7 core Fo72	19.79(25)	19.67	18.7	20.14		
SH9 Fo67.6 Mnt 62	21.35(16)	21.46	20.58	21.43		
SH11 small Fo64	23.65(17)	23.86	23.70	24.12		
SH9 Fo62.6 Mnt 62	24.66(13)	24.19	23.83	24.46		
SH11 #11 small Fo52	30.21(18)	30.31	29.21	29.36		
Wards Fayalite Mnt 61	50.79(23)	48.26	48.21	51.48		
Rockport Fayalite Mnt 30	52.27(23)	48.33	47.79	50.23		
Synthetic Fayalite Mnt 61	54.55(33)	52.03	53.48	55.00		
Fe metal #1	100.0	99.98	99.99	100.00		
Fe metal #2	100.0	100.00	100.00	99.99		

- 938 **Table III.** Quantification of a second set of olivines at 7 kV and 90 nA using the area k-ratio
- 939 calibration curve with the SXFiveFE microprobe and three WDSs. Nominal refers to the 15 kV
- 940 measurements using the traditional Fe Ka X-ray line. Numbers in parenthesis are the estimated
- 941 standard deviations (uncertainties on the last digits).

Sample name	Fe concentration (wt%)					
1	Nominal	Sp1 (LTAP)	Sp2 (TAP)	SP4 (PC0)		
WKOL #1	4.11(14)	3.92	4.34	3.54		
HaKOL g3 #8	5.98(6)	6.22	6.32	5.44		
UWOL-1 #4	7.94(4)	8.01	8.64	7.19		
SWOL-1 #2	13.22(8)	13.05	13.71	12.63		
SWOL-1 #2 ROM	13.22(8)	13.67	14.00	12.97		
KNOL-2 #6	15.44(11)	15.41	15.60	14.04		
FJOL #5	18.76(8)	18.68	18.62	18.04		
OROL #20	26.78(4)	26.88	26.77	25.93		
Rockport Fayalite Mnt 30						
Rand	52.50(23)	51.74	50.48	52.29		
Synthetic Fayalite Mnt 61						
(new pos)	54.80(33)	53.44	52.98	52.24		
Fe metal	100.0	99.99	99.99	99.99		

- 944 Table IV. Re-quantification of the Fe concentration of the two sets of olivines using the
- 945 calibration curves obtained using the Fe L α peak maximum. The results were obtained at 7 kV
- 946 and 90 nA with the SXFiveFE microprobe and three WDSs. Numbers in parenthesis are the
- 947 estimated standard deviations (uncertainties on the last digits).

	Fe concentration (wt%)				
		SXFiveFE			
Somnlo nomo	Nominal	Sp1	Sp2	Sp4	
Sample hame		(LTAP)	(TAP)	(PC0)	
First olivine set					
USNM San Carlos	7.64(12)	7.38	7.73	7.23	
USNM Springwater	13.14(16)	12.75	12.63	12.57	
SH15	18.64(19)	19.56	18.55	18.88	
SH9	21.25(20)	22.24	21.98	21.53	
SH25	26.34(22)	28.01	28.51	26.45	
SH11	30.16(24)	31.75	31.08	30.89	
SH111	32.59(24)	35.06	33.25	33.07	
Wards Fayalite	50.44(30)	50.74	51.39	49.99	
Synthetic Fayalite	53.90(31)	52.43	52.19	53.03	
Fe metal	100.0	99.60	99.60	99.55	
Second olivine set					
WKOL #1	4.11(14)	3.98	3.85	4.16	
HaKOL g3 #8	5.98(6)	5.86	5.98	6.37	
UWOL-1 #4	7.94(4)	7.52	7.41	8.22	

SWOL-1 #2	13.22(8)	13.05	13.43	13.98
KNOL-2 #6	15.44(11)	13.41	14.19	14.66
FJOL #5	18.76(8)	17.95	18.50	18.95
OROL #20	26.78(4)	26.49	27.30	27.59
Rockport Fayalite Mnt 30				
Rand	52.50(23)	51.74	51.41	52.03
Synthetic Fayalite Mnt 61				
(new pos)	54.80(33)	52.81	53.18	53.55
Fe metal	100.0	99.60	99.60	99.55

948

- 950 **Table V.** Reevaluation of the Fe concentration of the first set of olivines using the calibration
- 951 curves obtained using the Fe Lα peak maximum. The results were obtained at 7 kV and 90 nA
- 952 with the SX51 microprobe and three WDSs. Numbers in parenthesis are the estimated standard
- 953 deviations (uncertainties on the last digits).

Sample name	Fe concentration (wt%)					
1		SX51				
First olivine set	Nominal	Sp1 (TAP)	Sp2 (TAP)	Sp4 (PC0)		
Coarse San Carlos	7.46(77)	6.94	6.98	7.13		
USNM Springwater	13.20(7)	11.52	12.08	12.43		
SH11 Fo72	19.79(25)	19.26	19.02	19.80		
SH9 Fo67	21.70(30)	21.43	20.77	21.46		
SH111 Fo47 #1	32.12(22)	33.69	33.90	33.30		
SH111 Fo47 #2	32.12(22)	33.76	33.39	33.08		
SH111 Fo47 #3	32.12(22)	33.69	33.90	33.30		
Wards Fayalite	50.90(39)	50.02	49.67	49.91		
Rockport Fayalite	52.29(26)	52.03	52.07	51.52		
Synthetic Fayalite	54.55(33)	52.18	52.56	53.17		
Fe metal	100.0	99.61	99.61	99.56		

Figure 1



Always consult and cite the final, published document. See http://www.minsocam.org or GeoscienceWorld



Always consult and cite the final, published document. See http://www.minsocam.org or GeoscienceWorld



Always consult and cite the final, published document. See http://www.minsocam.org or GeoscienceWorld











